

Application/Control No.	Applicant(s)/Patent under Reexamination
10/709,237	NATARAJAN ET AL.
Examiner	Art Unit
John B. Nguyen	2819

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Class	Subclass	Date	Examiner
341	101,100	7/11/2005	JN
340	50-53		
326	38,39		
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326	37	7/11/2005	JN
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